TriQuint SEMICONDUCTOR

TGA2512-SM

4 - 14 GHz Balanced LNA

Self Bias

Gate Bias

Key Features

- Frequency Range: 4 – 14.2 GHz
- 2.3 dB Nominal Noise Figure
- 25 dB Nominal Gain
- 15 dB AGC Range
- 13 dBm Nominal P1dB
- 24dBm Nominal OIP3
- Bias: 5 V, 160 mA Gate Bias
  5 V, 90 mA Self Bias
- Package Dimensions:
  4.0 x 4.0 x 0.9 mm

Primary Applications

- X-Band Radar
- EW, ECM
- Point-to-Point Radio

Product Description

The TriQuint TGA2512-SM is a packaged X-band balanced LNA with AGC amplifier for EW, ECM, and RADAR receiver or driver amplifier applications. The TGA2512-SM provides excellent noise performance with typical midband NF of 2.3dB, and high gain, 25dB from 4-14.2GHz

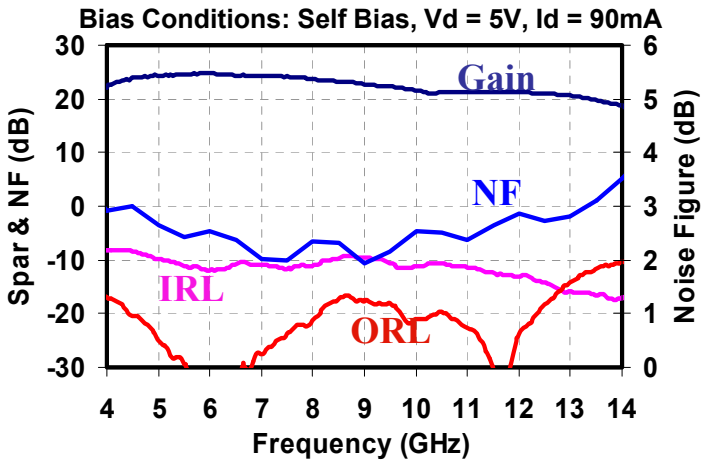
The TGA2512-SM is designed for maximum ease of use. TGA2512-SM can handle up to 21dBm input power reliably, while the build-in gain control provides 15dB of typical gain control range. The part can be used in self-biased mode, with a single +5V supply connection, or in gate biased mode, allowing the user to control the current for a particular application.

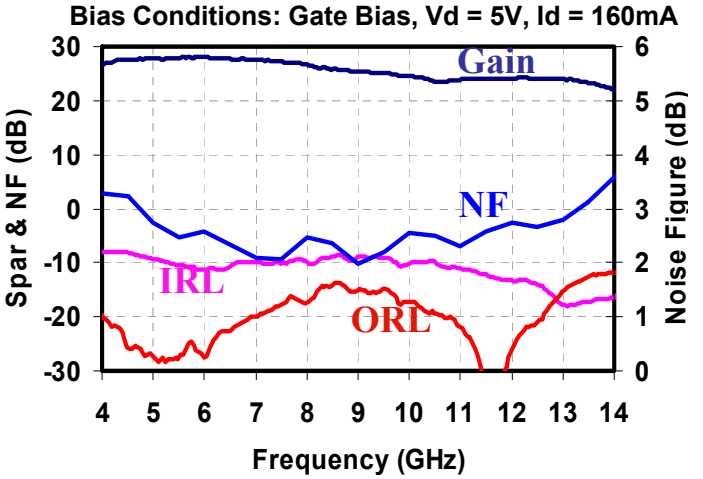
In self-biased mode the TGA2512-SM achieves 6dBm typical P1dB, while in gate-biased mode the typical P1dB is over 13dBm.

Lead-Free & RoHS compliant.

Evaluation boards are available.

Measured Data





Datasheet subject to change without noitce

TriQuint Semiconductor: www. triquint.com (972)994-8465 Fax (972)994-8504 Info-mmw@tqs.com

TABLE I
MAXIMUM RATINGS 1/

SYMBOL	PARAMETER	VALUE	NOTES
Vd	Drain Voltage	Gate Bias: [4 + (0.009)(Id)] V Self Bias: [3.5 + (0.022)(Id)] V	2/ 3/
Vg	Gate Voltage Range	-1 TO +0.5 V	
Id	Drain Current (gate biased)	240 mA	2/
$\lvert Ig \rvert$	Gate Current	7.04 mA	
P_{IN}	Input Continuous Wave Power	21 dBm	
P_D	Power Dissipation	1.56 W	2/ 4/
T_{CH}	Operating Channel Temperature	200 °C	5/
	Mounting Temperature (30 Seconds)	260 °C	
T_{STG}	Storage Temperature	-65 to 150 °C	

1/ These ratings represent the maximum operable values for this device.

2/ Combinations of supply voltage, supply current, input power, and output power shall not exceed P_D.

3/ Unit for Id is mA

4/ When operated at this bias condition with a base plate temperature of 85 °C, the median life is 9.3E4 hours.

5/ Junction operating temperature will directly affect the device median time to failure (Tm).

For maximum life, it is recommended that junction temperatures be maintained at the lowest possible levels.

TABLE II-A

ELECTRICAL CHARACTERISTICS

(Ta = 25 ^{0}C, Nominal)

PARAMETER	Self Bias TGA2512-1-SM	Gate Bias TGA2512-2-SM	UNITS
Frequency Range	4 – 14.2	4 – 14.2	GHz
Drain Voltage, Vd	5.0	5.0	V
Drain Current, Id	160	160	mA
Gate Voltage, Vg	-	-0.1	V
Small Signal Gain, S21	22	25	dB
Input Return Loss, S11	-10	-10	dB
Output Return Loss, S22	-20	-20	dB
Noise Figure, NF	2.3	2.3	dB
Output Power @ 1dB Gain Compression, P1dB	6	13	dBm
OIP3	16	24	dBm
Temperature Gain Coefficent	-0.02	-0.02	dB/°C

Note: Table II Lists the RF Characteristics of typical devices as determined by fixtured measurements.

TABLE II-B

TGA2512-2-SM ELECTRICAL CHARACTERISTICS

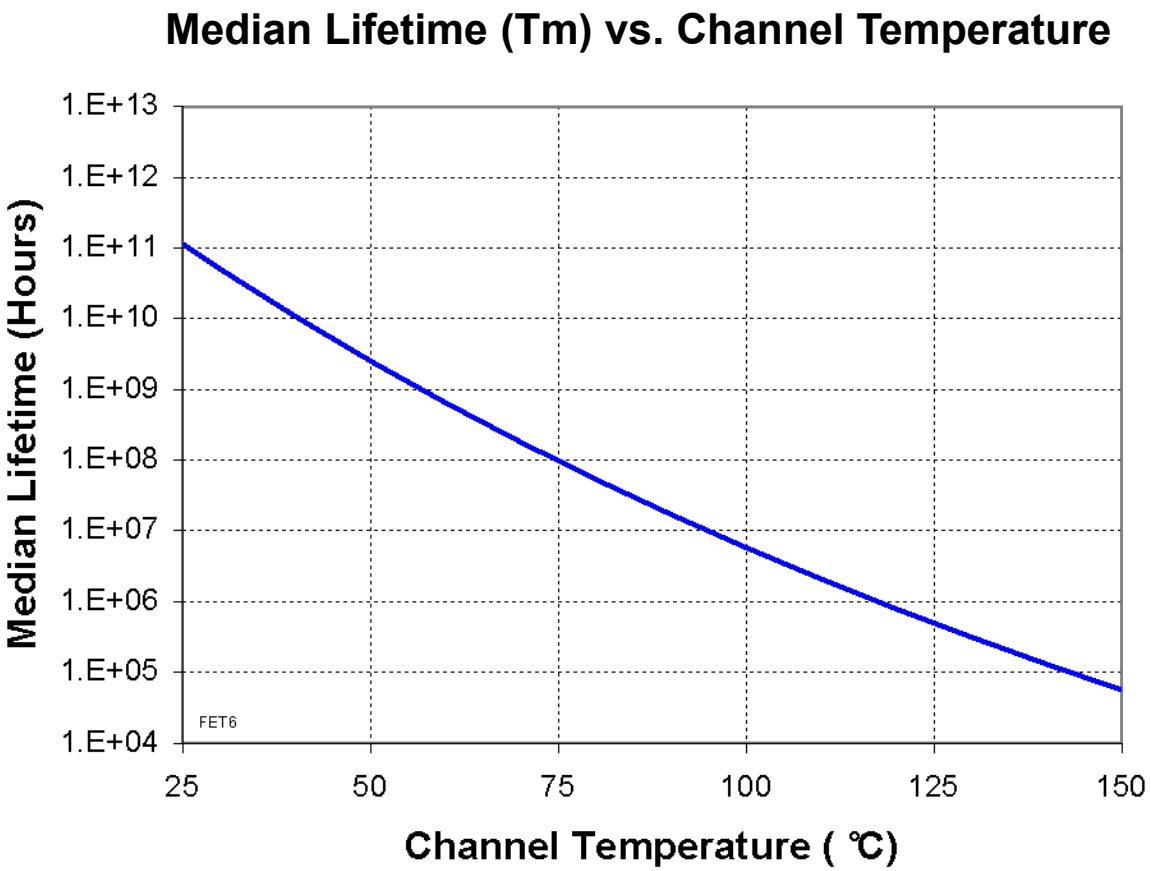
(Vd=5V, Id=160mA, Vctrl=0V, Ta = 25 ^{0}C, Nominal)

PARAMETER	Min	Typ	Max	UNITS
Frequency Range	11		14.2	GHz
Drain Current, Id		160	200	mA
Gate Voltage, Vg	-0.4	-0.1	0.2	V
Small Signal Gain, S21	19	24		dB
Input Return Loss, S11	-7	-12		dB
Output Return Loss, S22	-7	-12		dB
Noise Figure, NF		3	4.5	dB
Output Power @ 1dB Gain Compression, P1dB	10	13		dBm
OIP3	16	22		dBm

TABLE III
THERMAL INFORMATION

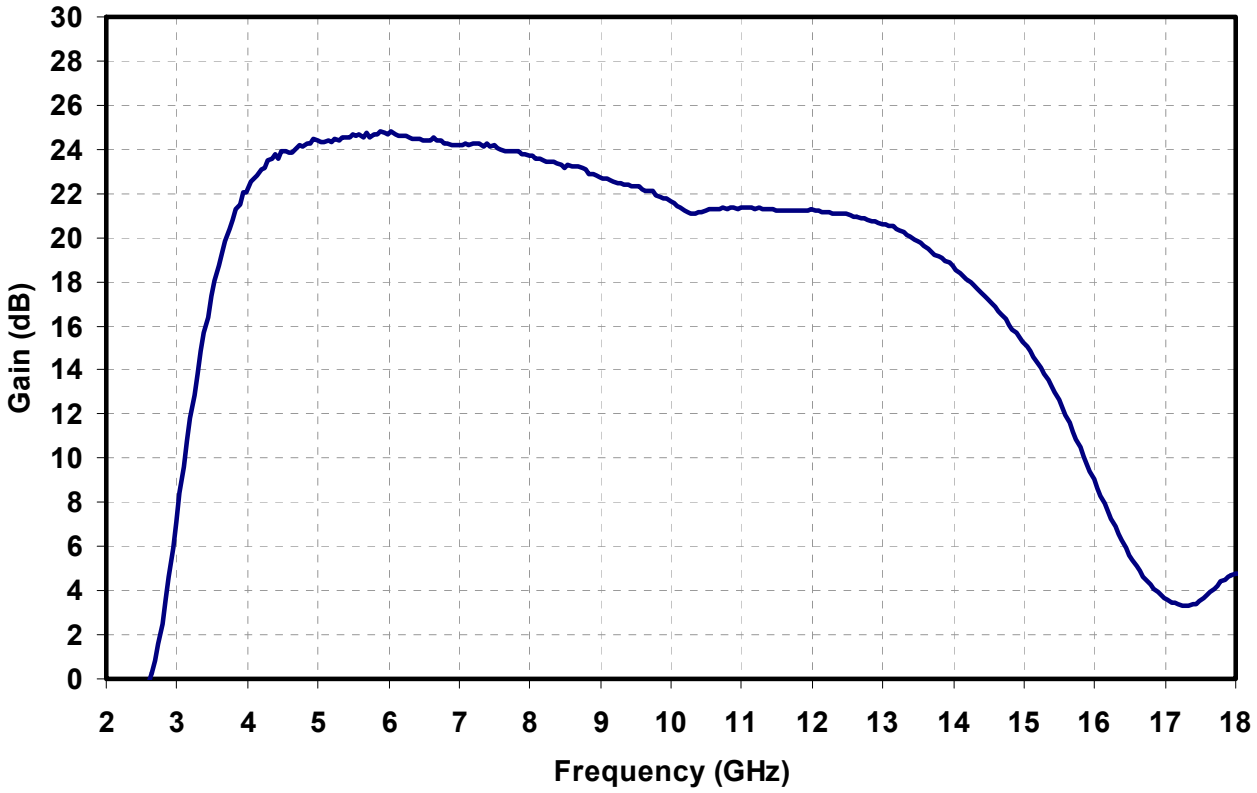
PARAMETER	TEST CONDITIONS	T_{CH} (°C)	θ_{JC} (°C/W)	T_m (HRS)
θ_{JC} Thermal Resistance (channel to Case)	Vd = 5 V Id = 160 mA Gate Bias Pdiss = 0.80 W	115	37.6	1.3E+6
θ_{JC} Thermal Resistance (channel to Case)	Vd = 5 V Id = 90 mA Self Bias Pdiss = 0.45 W	97.7	28.2	7.2E+6

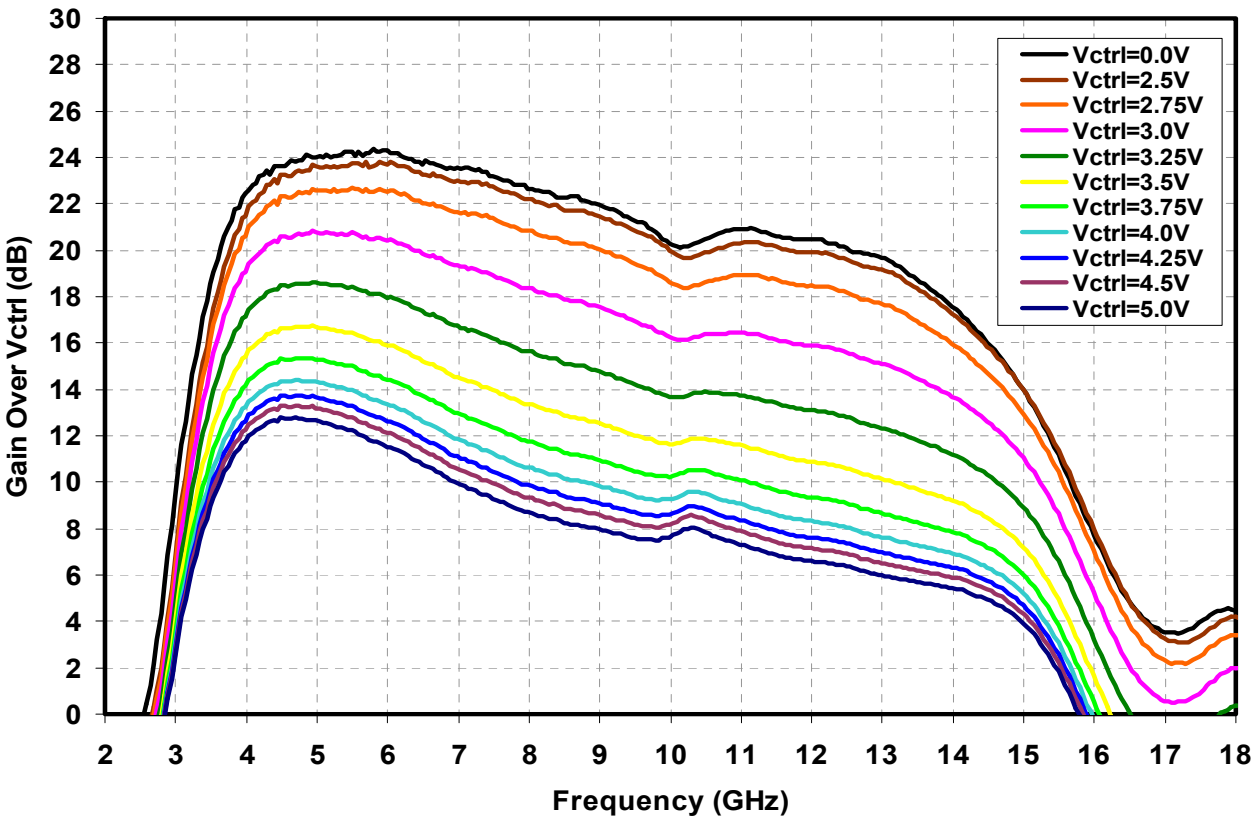
Note: Worst case condition with no RF applied, 100% of DC power is dissipated, Case Temperature at 85 °C



Measured Data

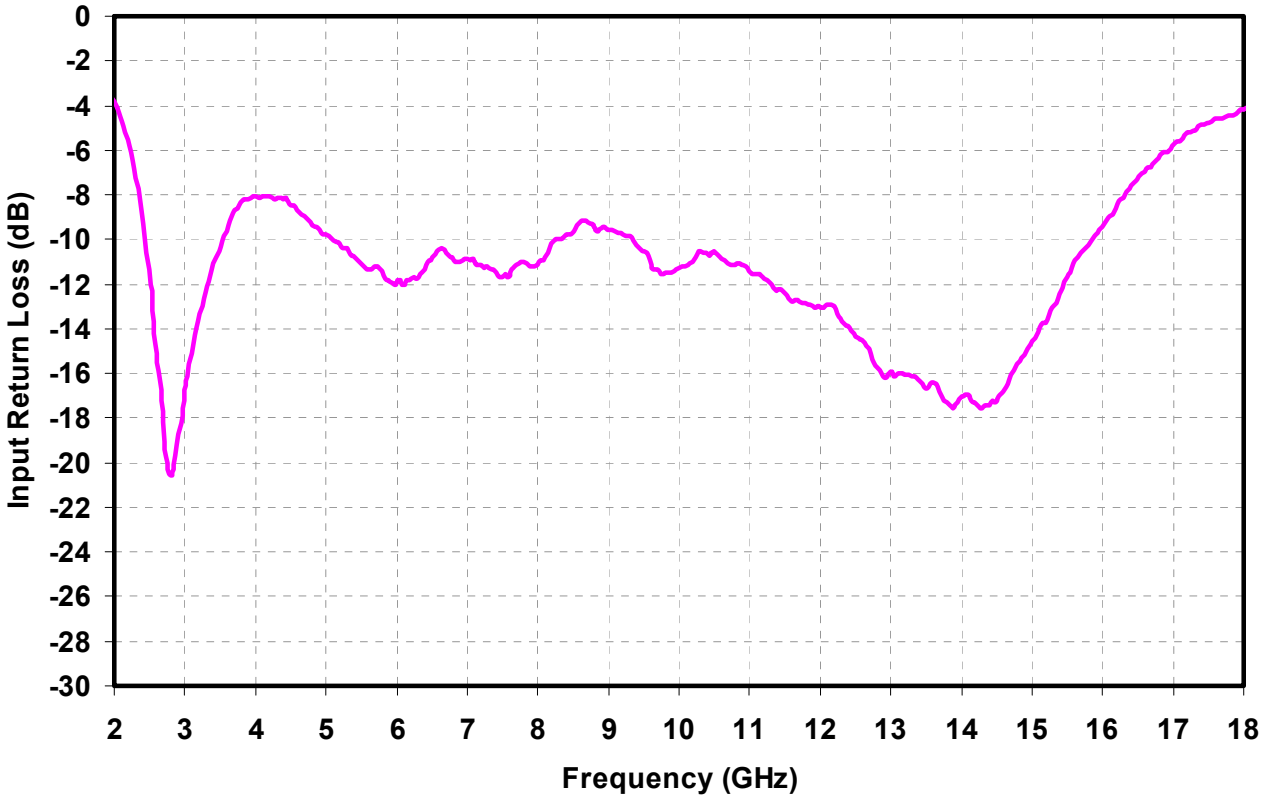
Bias Conditions: Self Bias, Vd = 5 V, Id = 90 mA

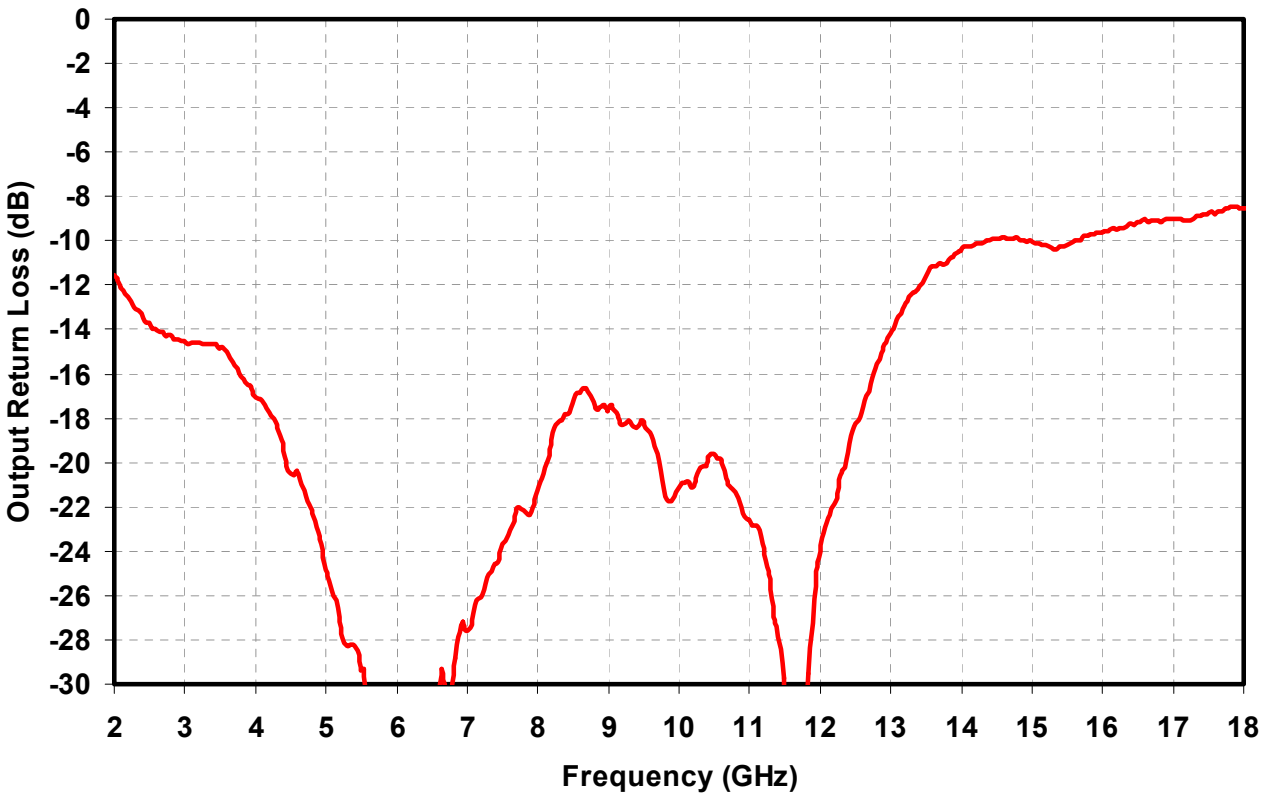




Measured Data

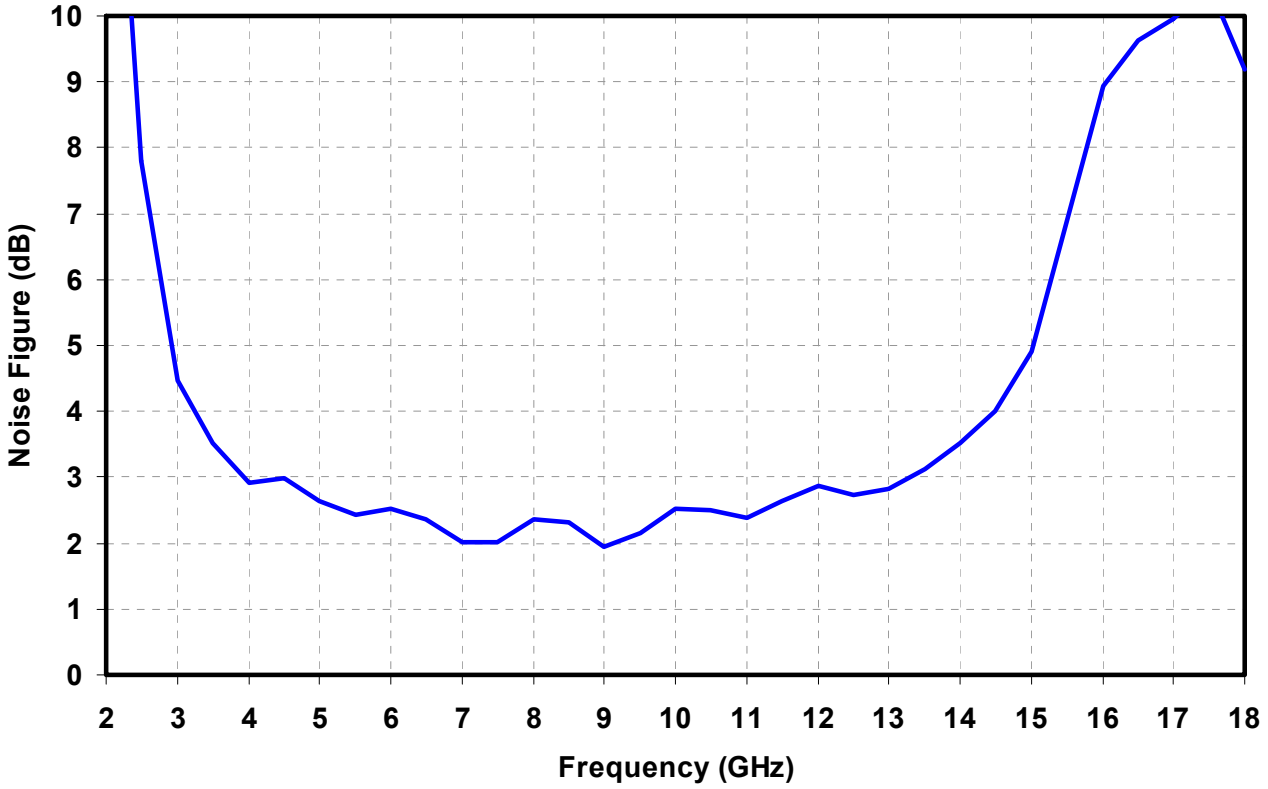
Bias Conditions: Self Bias, Vd = 5 V, Id = 90 mA

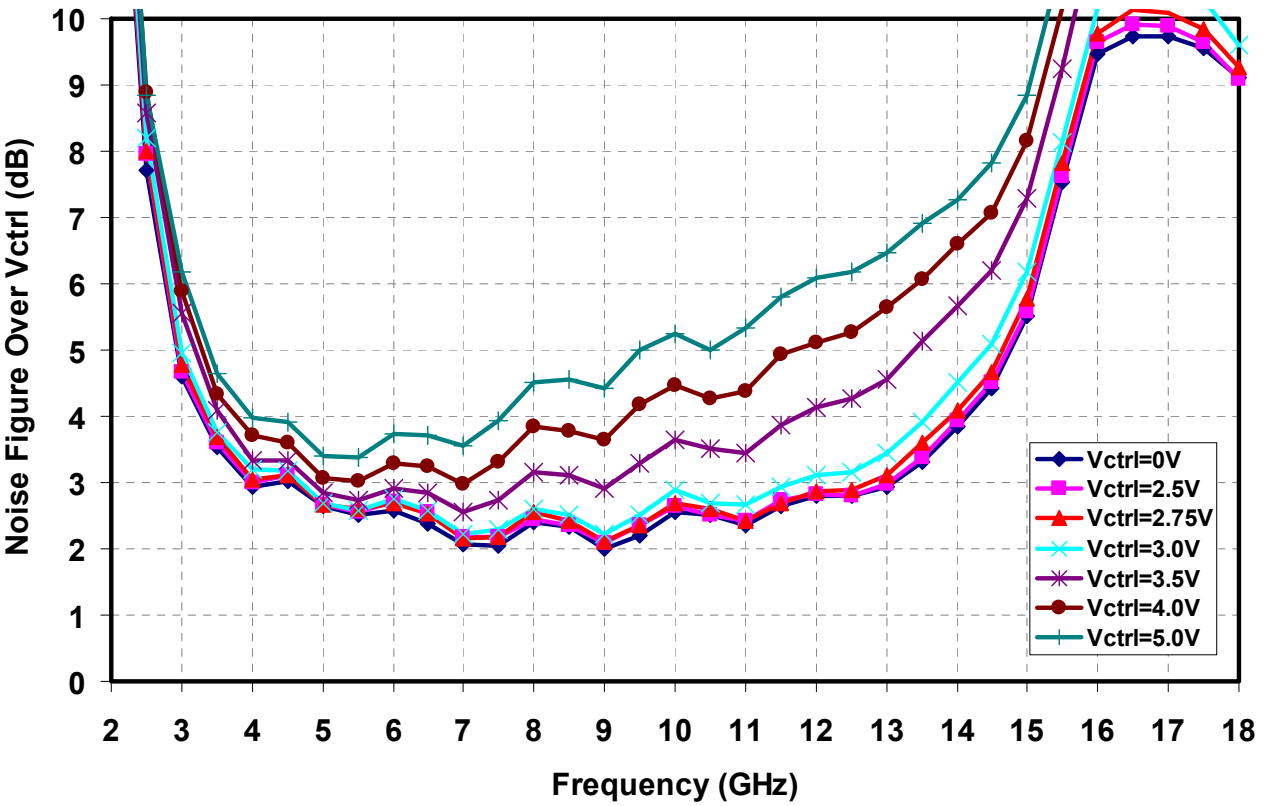




Measured Data

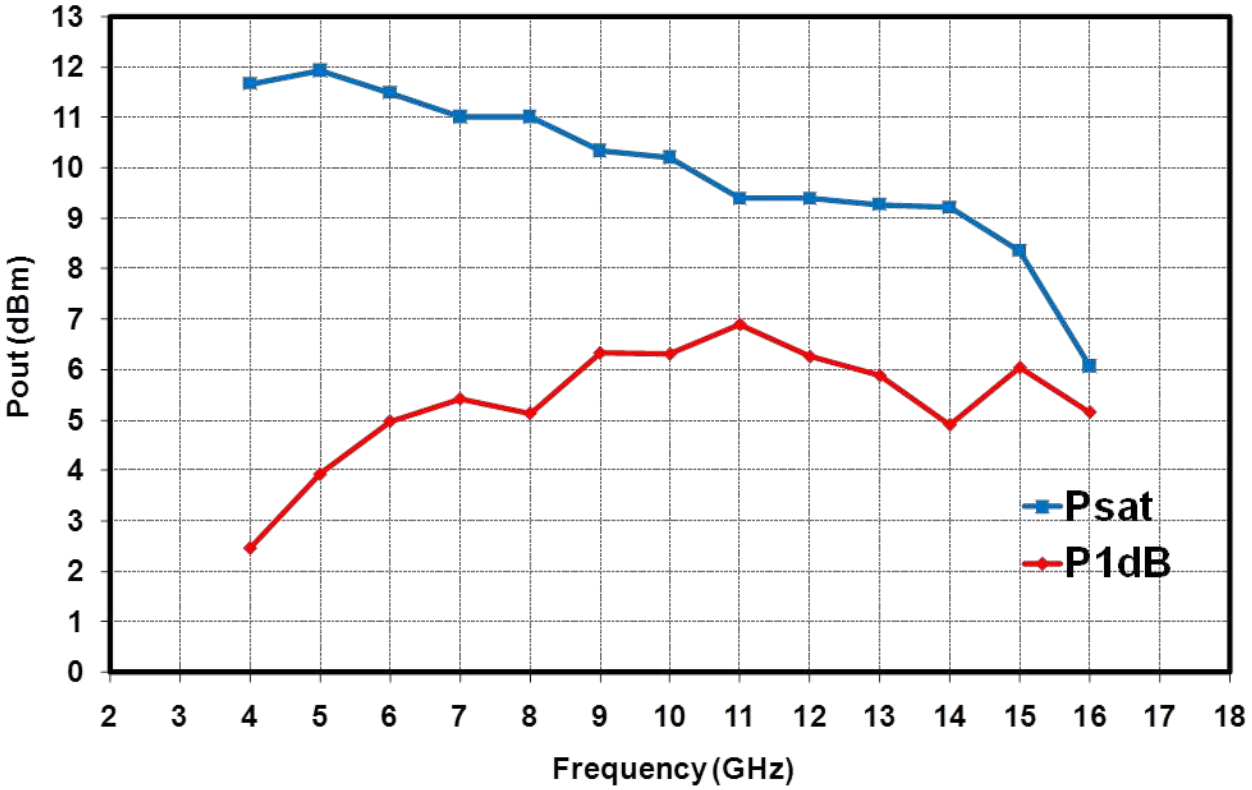
Bias Conditions: Self Bias, Vd = 5 V, Id = 90 mA

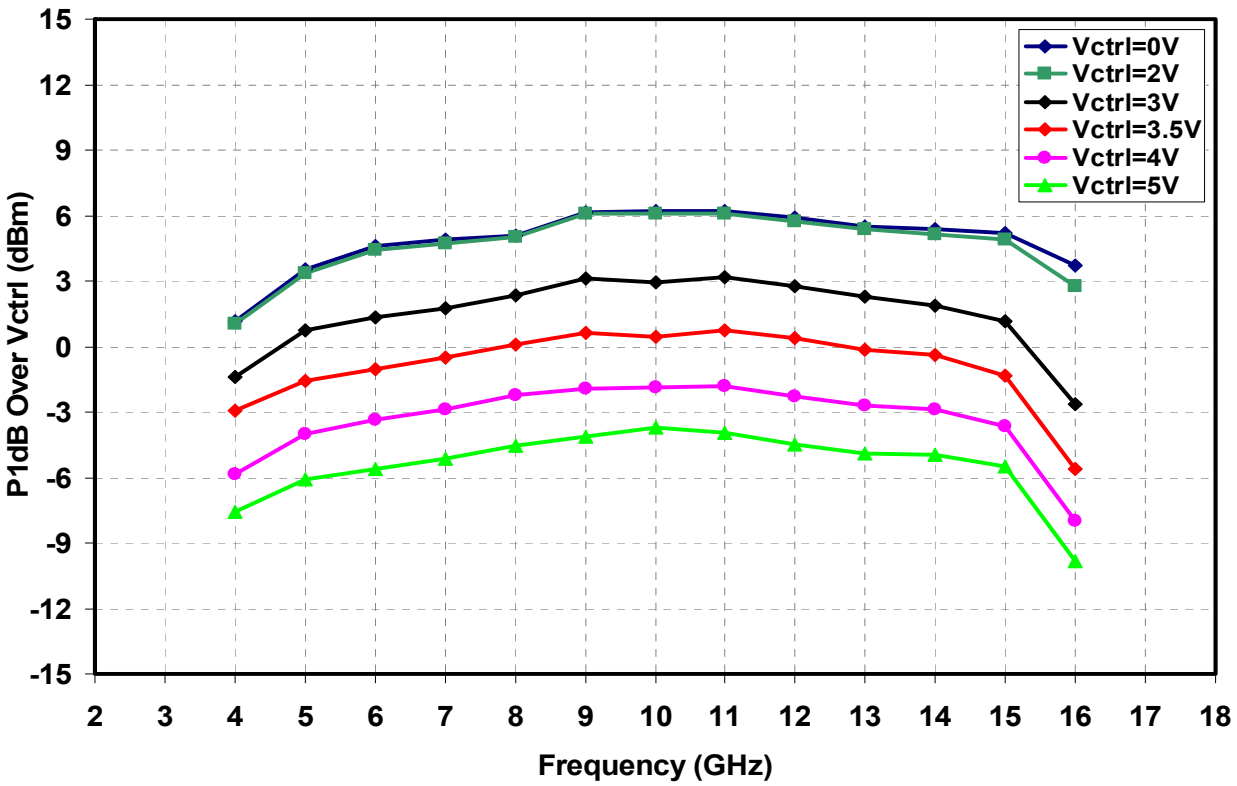




Measured Data

Bias Conditions: Self Bias, Vd = 5 V, Id = 90 mA

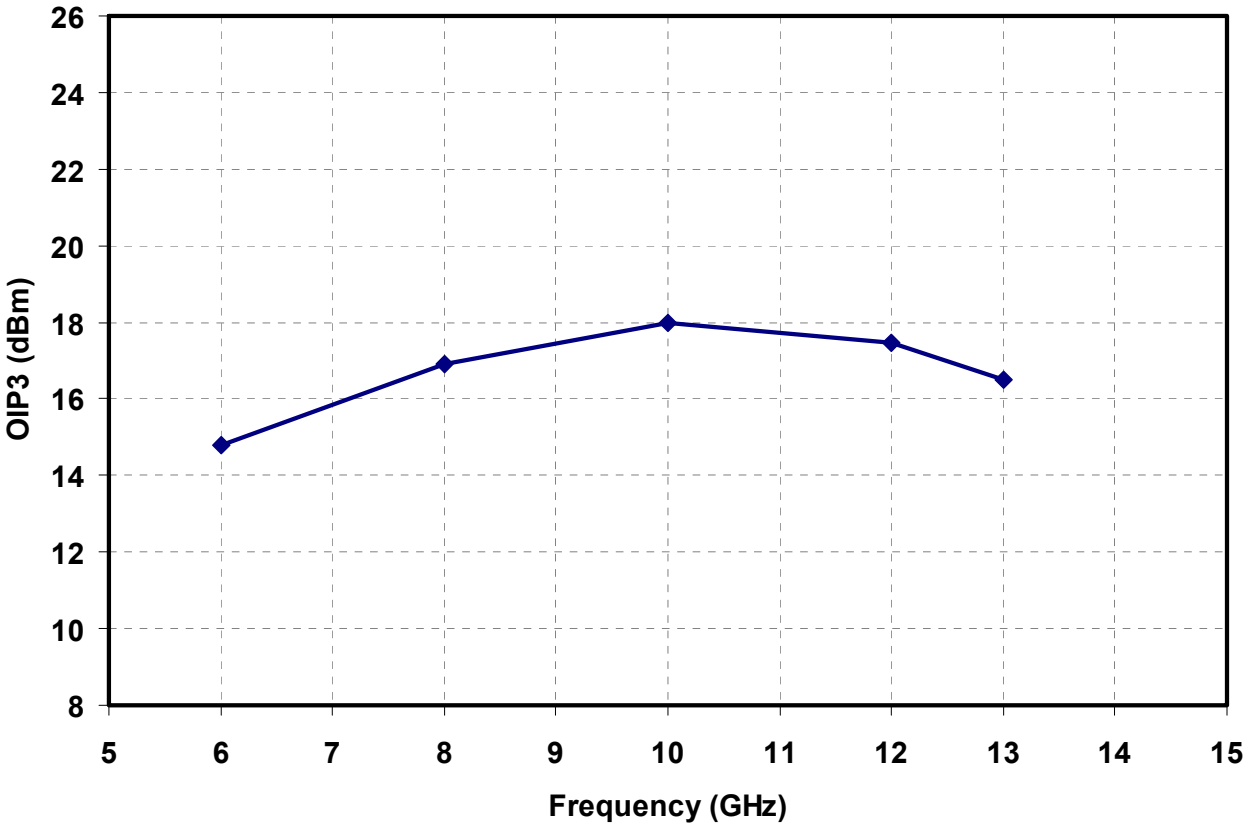




TriQuint Semiconductor: www. triquint.com (972)994-8465 Fax (972)994-8504 Info-mmw@tqs.com

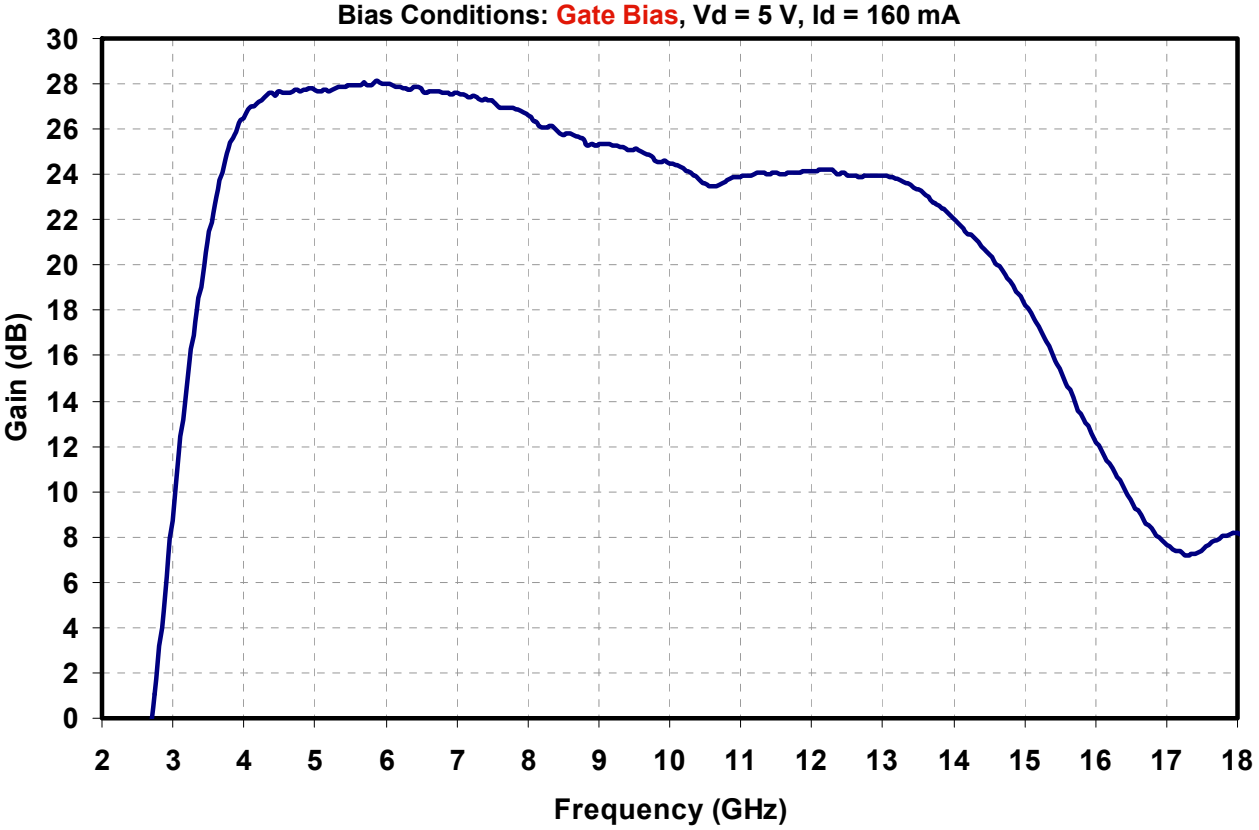
Measured Data

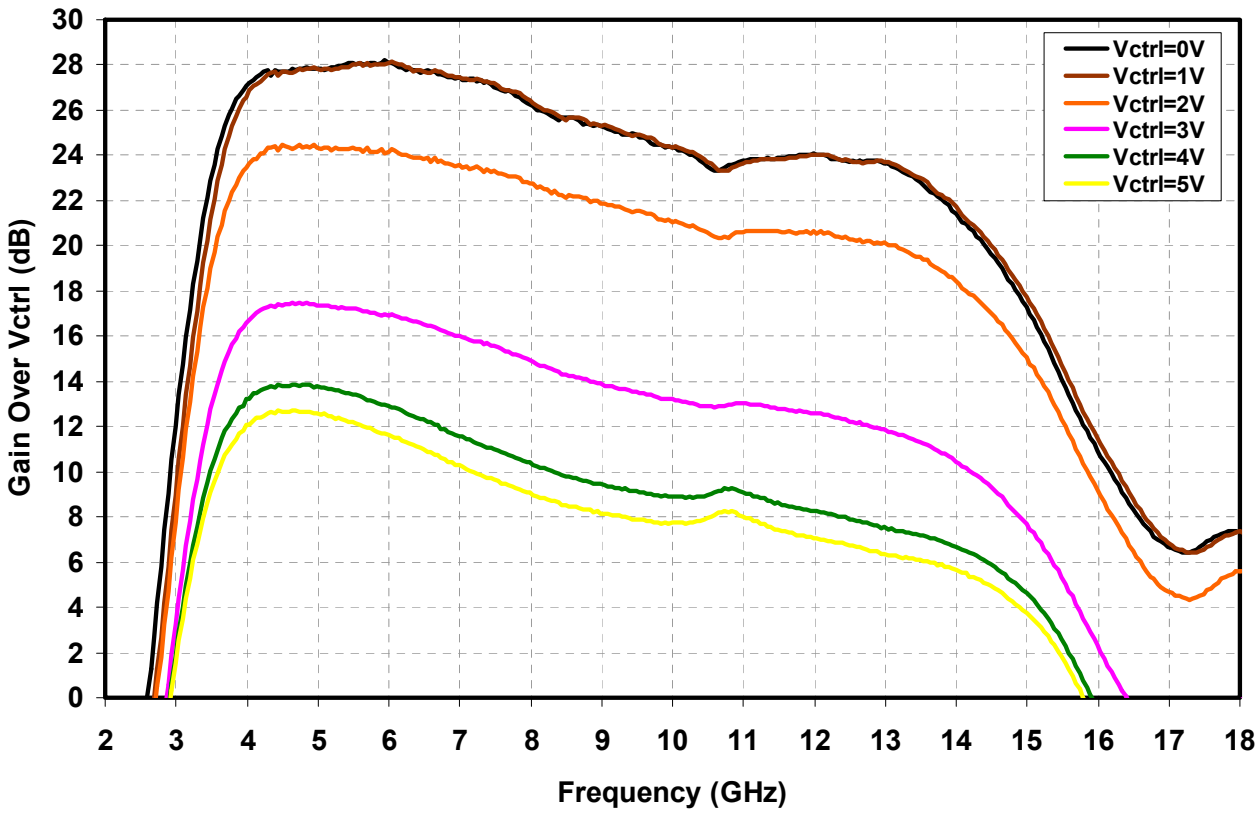
Bias Conditions: Self Bias, Vd = 5 V, Id = 90 mA



Measured Data

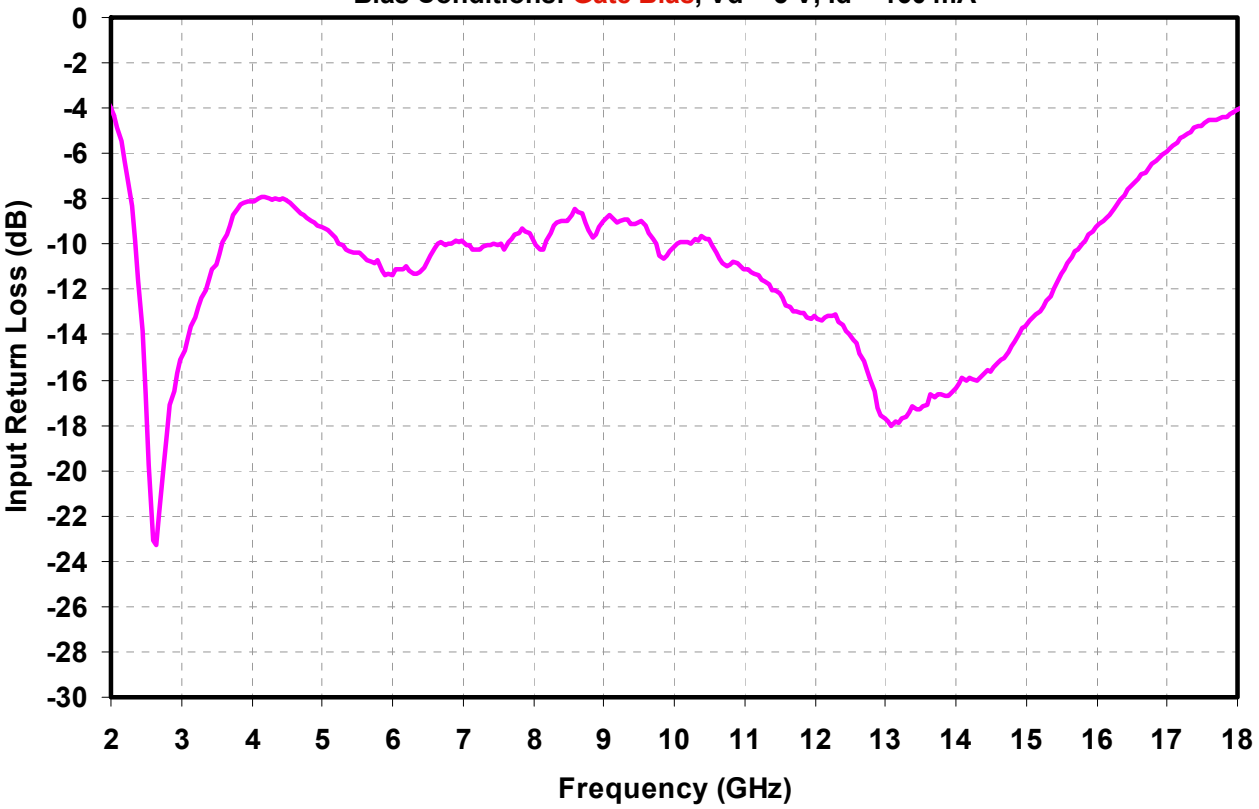
Bias Conditions: Gate Bias, Vd = 5 V, Id = 160 mA

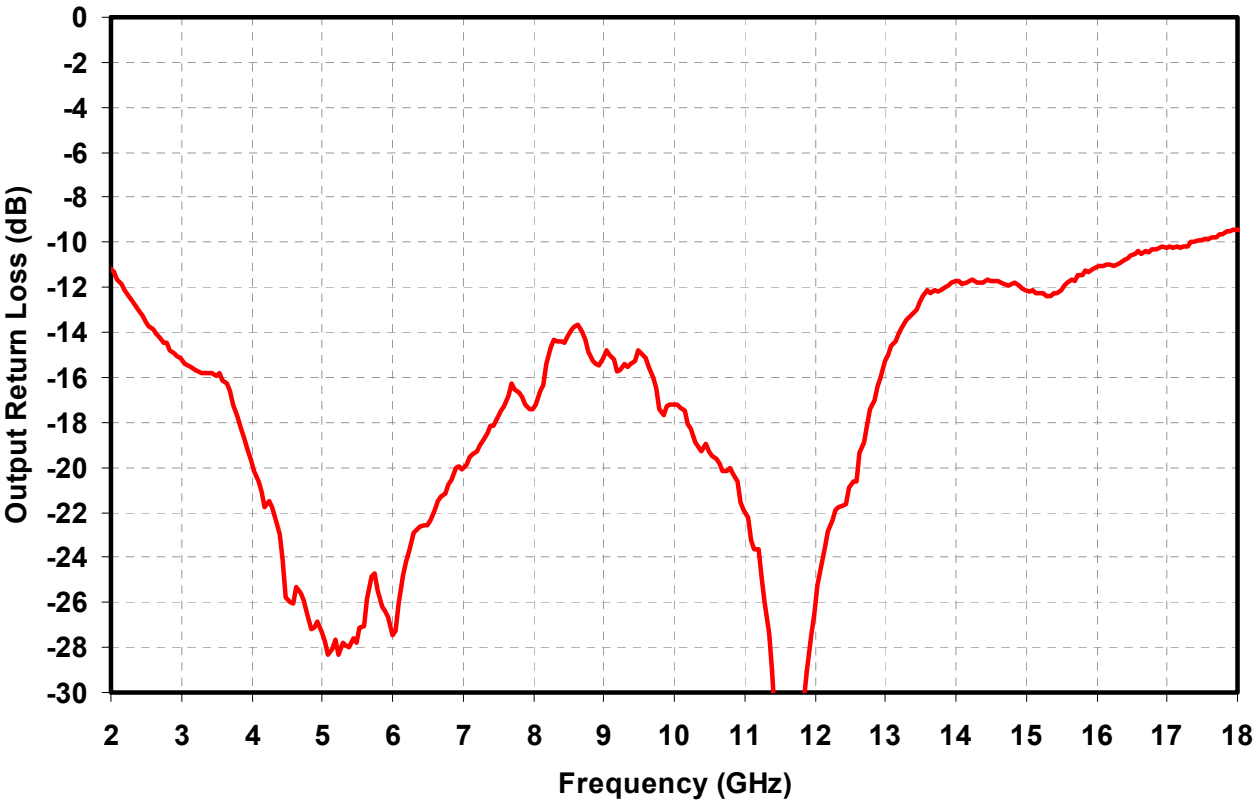




Measured Data

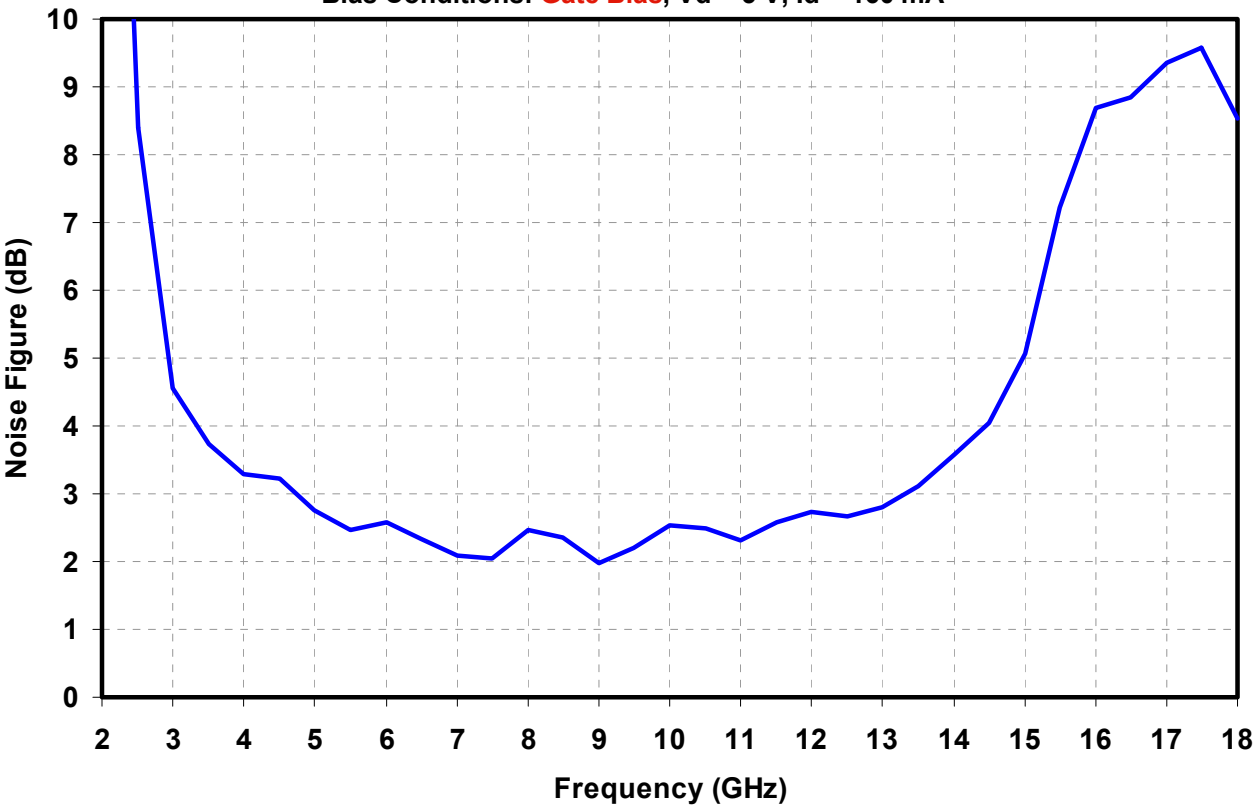
Bias Conditions: Gate Bias, Vd = 5 V, Id = 160 mA

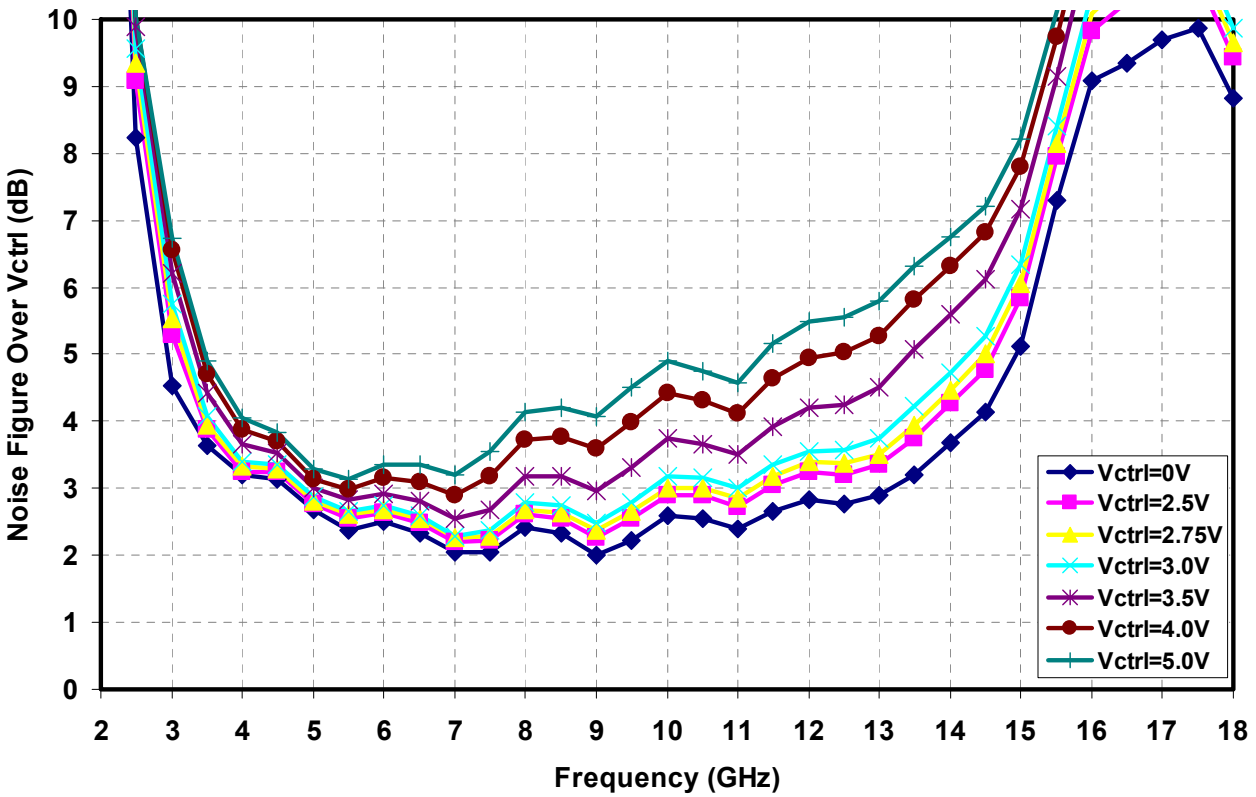




Measured Data

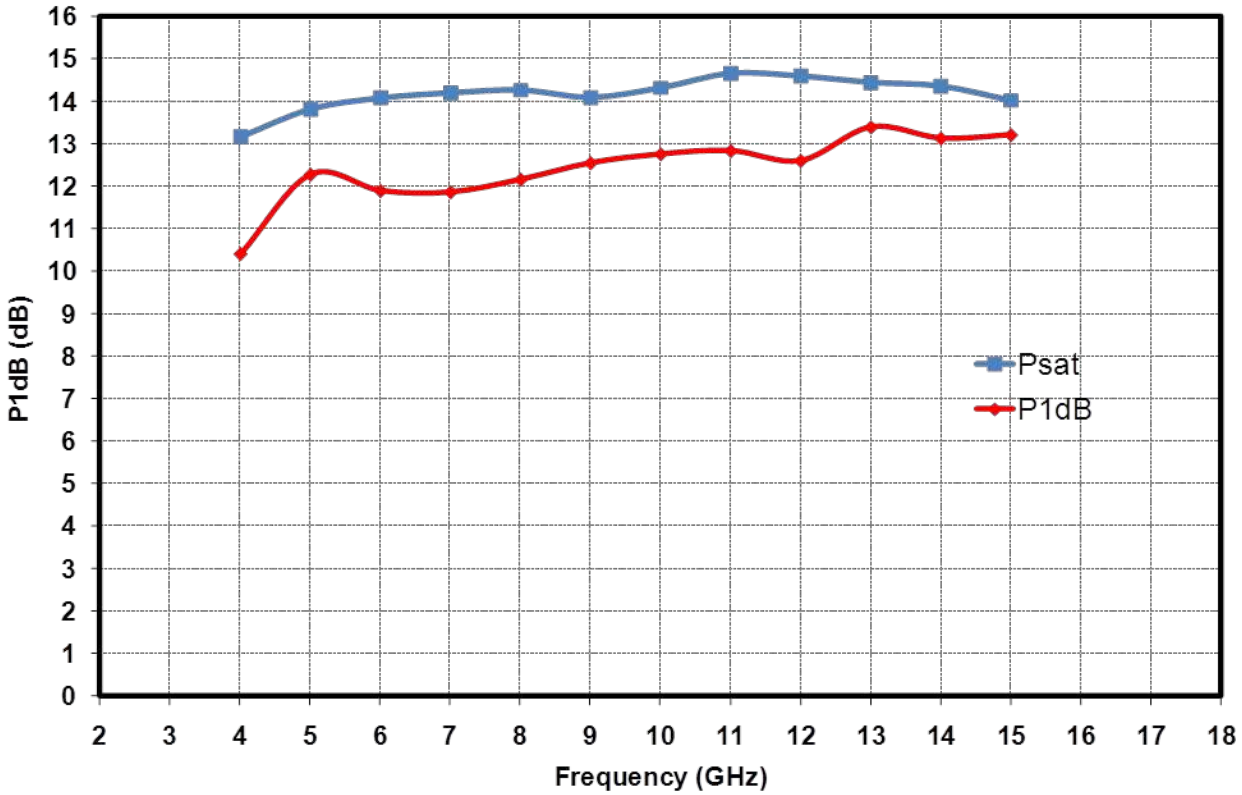
Bias Conditions: Gate Bias, Vd = 5 V, Id = 160 mA

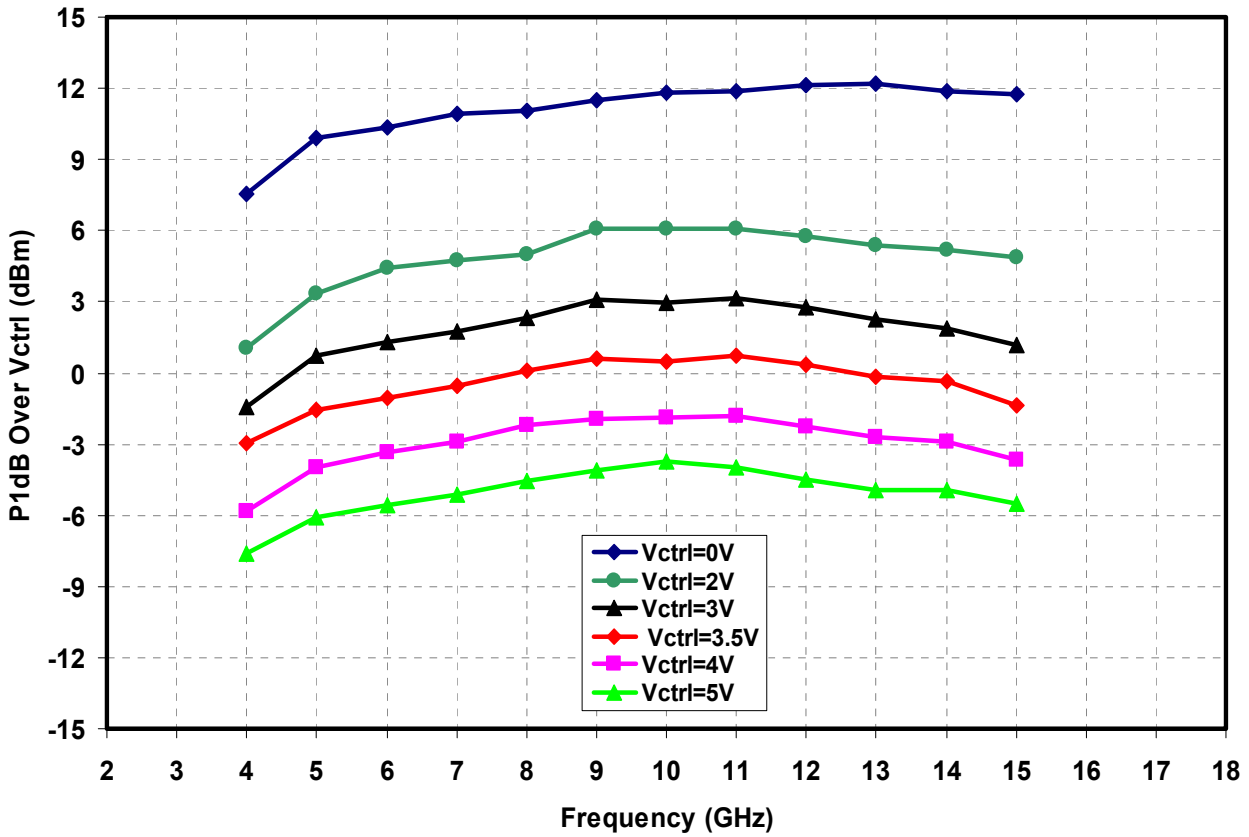




Measured Data

Bias Conditions: Gate Bias, Vd = 5 V, Id = 160 mA

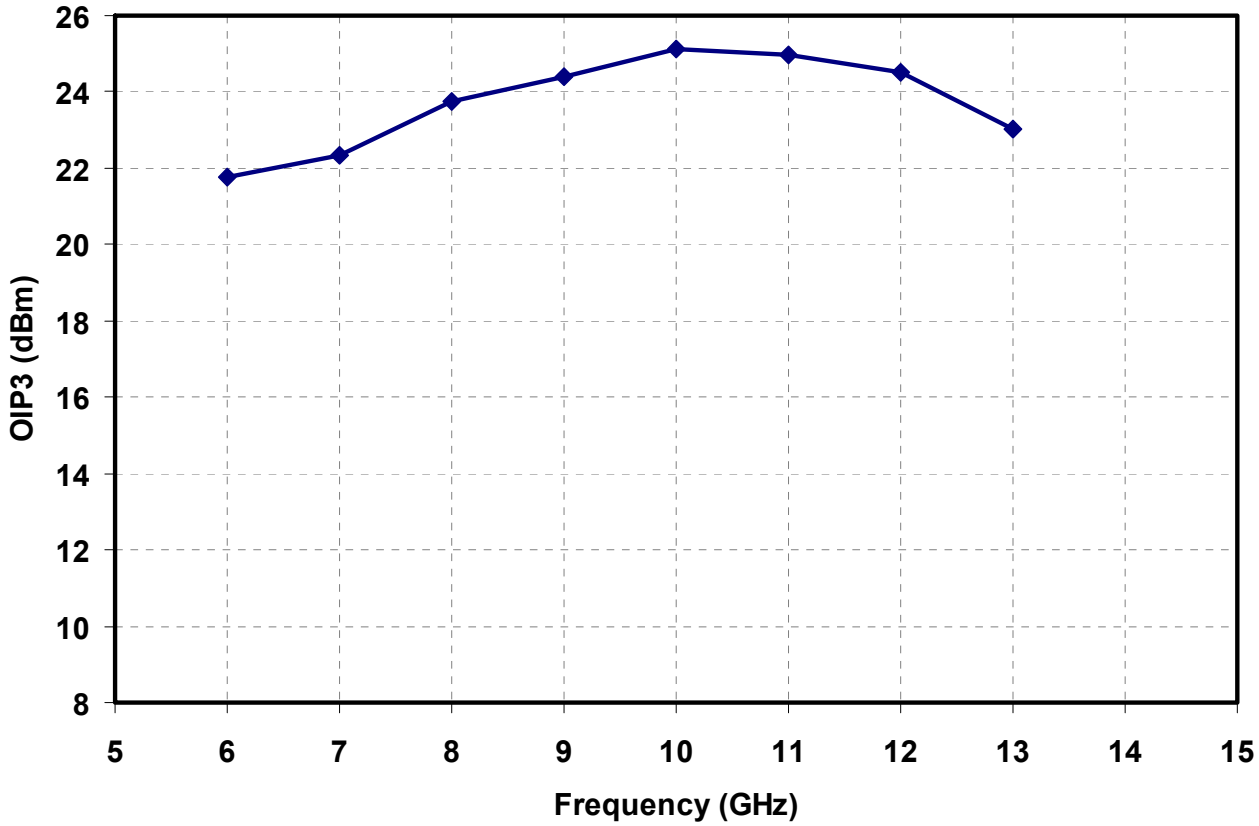




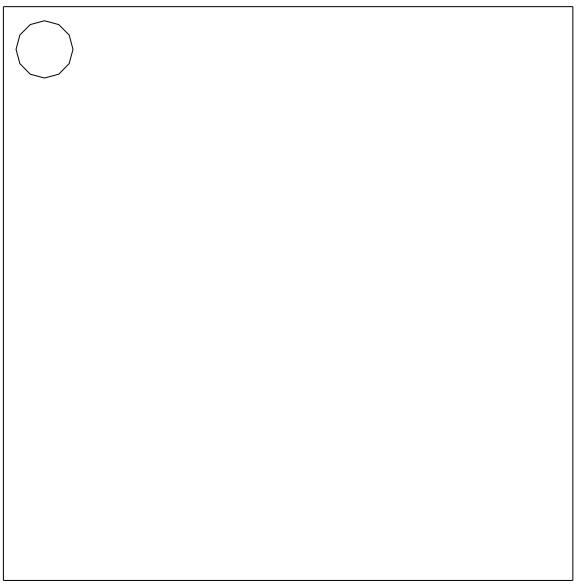
TriQuint Semiconductor: www. triquint.com (972)994-8465 Fax (972)994-8504 Info-mmw@tqs.com

Measured Data

Bias Conditions: Gate Bias, Vd = 5 V, Id = 160 mA

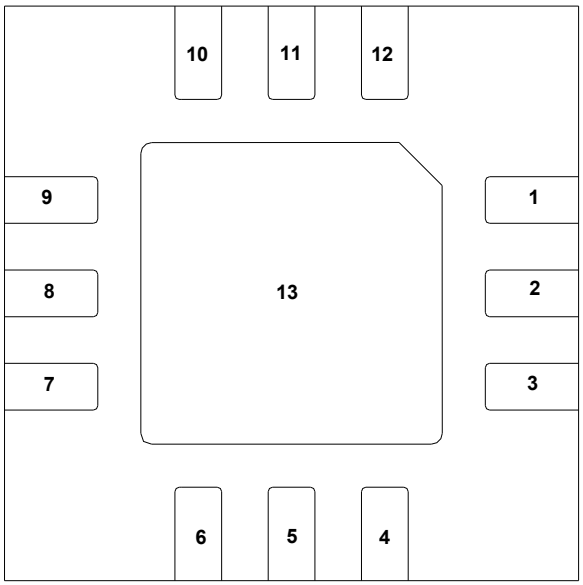


Package Pinout Diagram



Top View

Dot indicates Pin 1



Bottom View

Self Bias

Pin	Description
1,3, 4, 5, 6, 7, 9, 12	NC
2	RF Input
8	RF Output
10	Vd
11	Vctrl
13	Gnd

Self Bias: Vd = 5V (Id = ~90mA), Vctrl = 0 to +5V for Gain adjustment

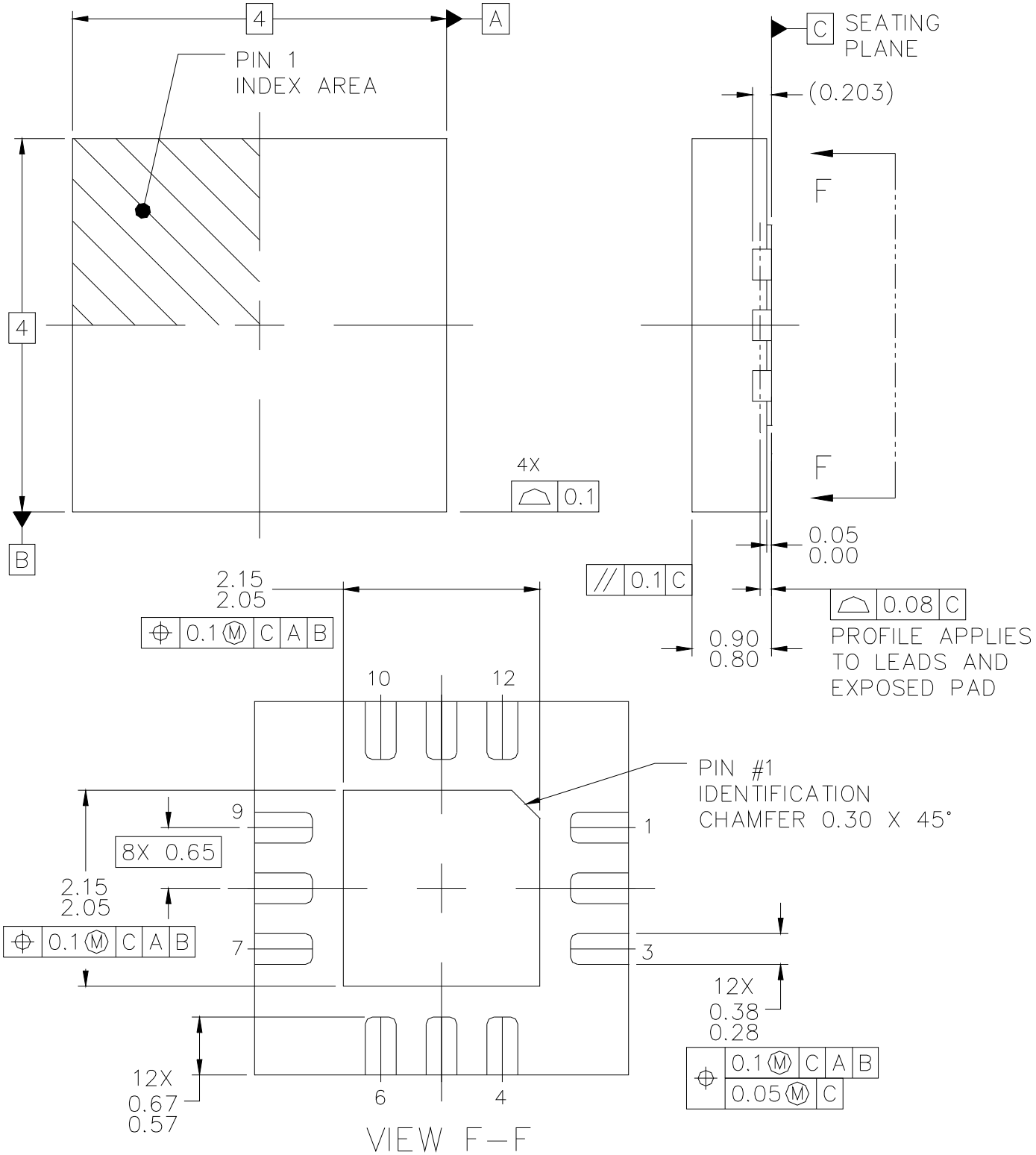
Gate Bias

Pin	Description
1,3, 4, 5, 6, 7, 9	NC
2	RF Input
8	RF Output
10	Vd
11	Vctrl
12	Vg
13	Gnd

Gate Bias: Vd = 5V , Vctrl = 0 to +5V for Gain adjustment
Vg = Range, -0.5 to 0, typically ~ -0.1 will provide ~160mA of Id.

Mechanical Drawing

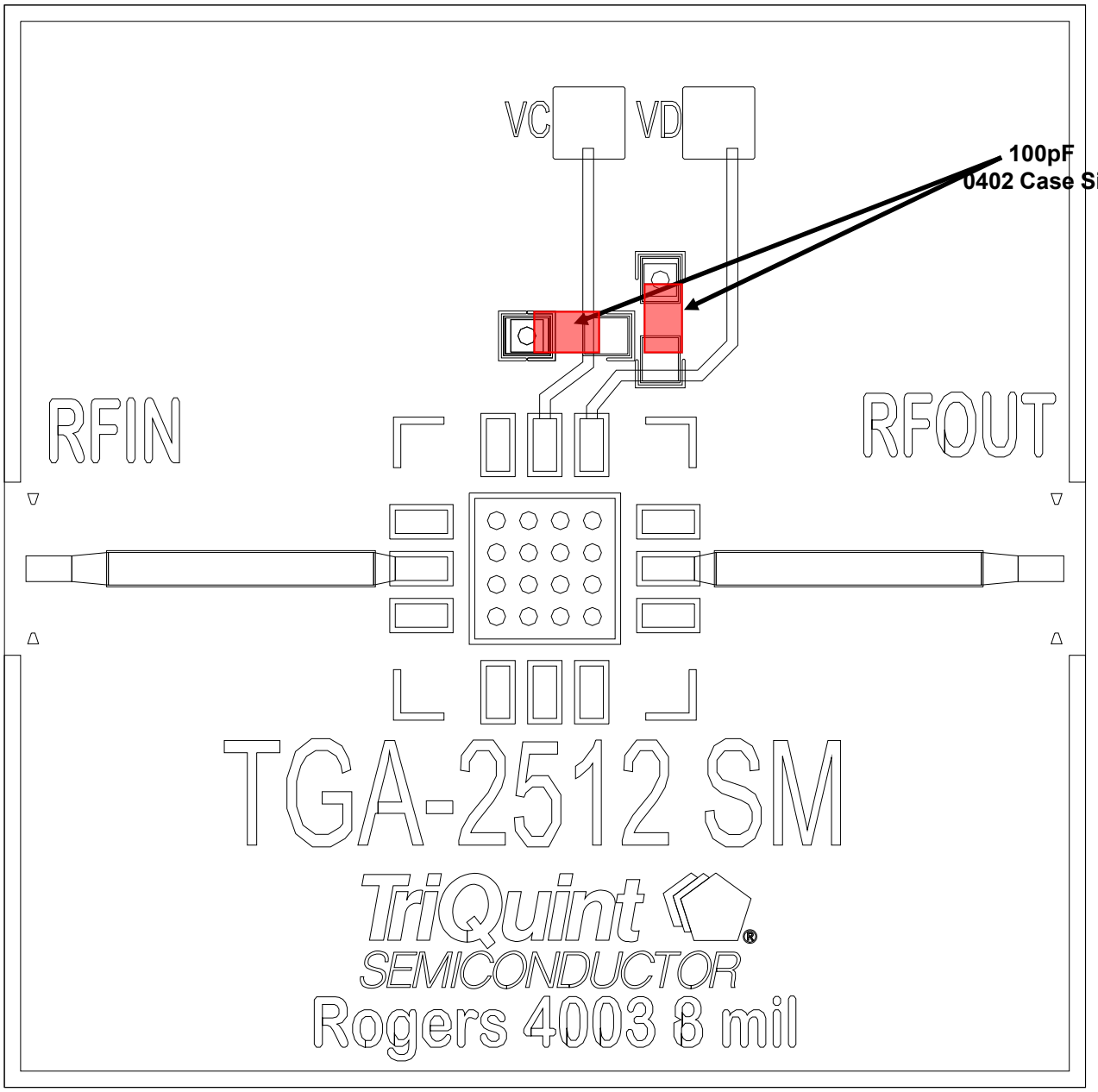
Units: Millimeters



GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.

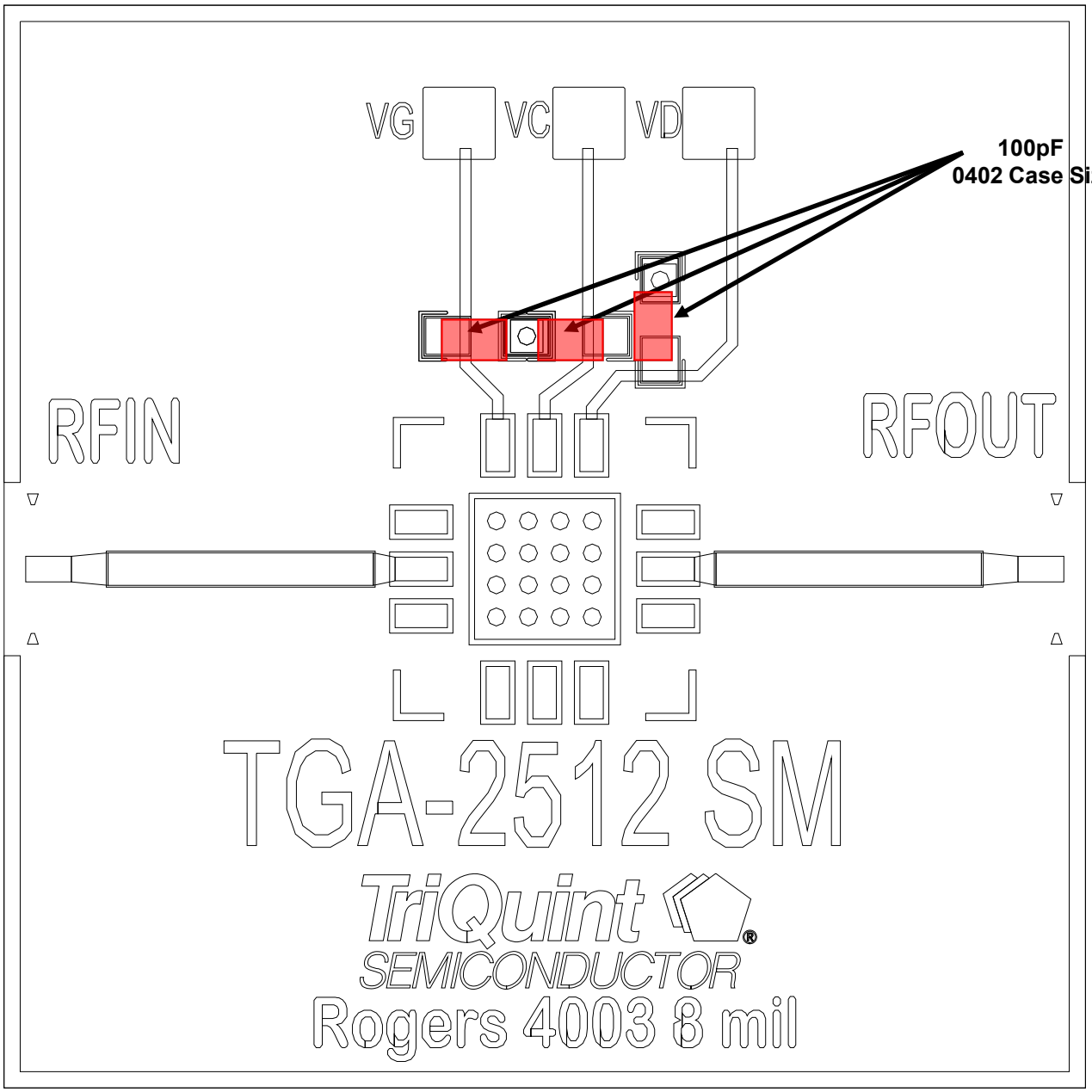
Recommended Board Layout Assembly

Self Bias



Recommended Board Layout Assembly

Gate Bias



TriQuint Semiconductor: www. triquint.com (972)994-8465 Fax (972)994-8504 Info-mmw@tqs.com

Ordering Information

Part	Package Style
TGA2512-1-SM	QFN 4x4 Surface Mount – Self Bias
TGA2512-2-SM	QFN 4x4 Surface Mount – Gate Bias